



Component Tester DB231

Fast and very accurate measurements at 1MHz, 100kHz, 10kHz and 1kHz



- 4 measuring frequencies: 1MHz, 100kHz, 10kHz and 1kHz
- Overall accuracy better than 0,05% and 2 x 10⁻⁴ for loss factor
- Especially suitable for ceramic, film, foil, and small tantalum capacitors, as well as all other CLR applications
- Built-in contact check function
- Very high measuring speed: 6 to 20ms from trig to end of measurement, depending of frequency
- Input protection: 2 Joule up to 1kV
- Measuring ranges: 0,1pF to 1mF depending of frequency
- Measures up to 0,9nF (0,2%) @ 1MHz
- Measuring cables: 1m or 39,3 inch (supplied as standard)
- Internal bias voltage: Up to ±3VDC on generator terminal, set in 0,1V steps.
- External bias voltage: Up to ±48VDC
- Average: 1 to 99 measurements
- CE approved
- Display readings: Direct or deviation capacitance and tan d or ESR for loss measurements and L/Q, Rs, Rp, Z
- Focused strategy on component testing for nearly 50 years

General

The DB231 Component Tester is specially designed for very high accuracy and automatic high-speed testing of capacitors. The instrument is reliable, user-friendly and easy to set up to any test application on production lines, in quality control departments or in laboratories.

The DB231 performs capacitance and loss factor tests at any of the 4 standard frequencies. Dual frequency tests at any combination of frequencies are possible as well. Or the user may set up a test sequence in order to perform multiple frequency testing, easily and quickly.

As standard the instrument has a built-in comparator for deviation measurements, IEEE488 (GPIB) and RS232C data interfaces as well as handler interface (opto-coupler type) with 12+4 bins for production sorting. The high-speed data interfaces may be used for an external computer in order to control the system, or for collection of data for statistics and analysis.

Bin sorting with up to 12 bins for capacitance for 1st frequency and up to 4 bins for tan δ using 2nd frequency. Or tan δ may be measured at several frequencies using the 4 bins for different levels of the dissipation factor.

The standard fitted PCMCIA card is the smart way of storing set-ups. Fail-safe loading of set-ups to several instruments will be done fast and efficient.

The test cables are as standard connected to the front panel of the instrument. Another possibility is to order the DB231 in the version MCR in order to have the test cables connected to the rear panel only. Test cable length of 1m or 39,3 inches is possible.

Tel: 0416 - 387 700



Specifications for DB231:

Measured Parameters: C, L, R, Z (serial or parallel)

Measuring Frequencies: 1MHz, 100k, 10k and 1kHz with multiple frequency facility

Measuring Voltages: 1 V RMS up to 10μ F at 1kHz 1 V RMS up to 1μ F at 10kHz

1 V RMS up to 100nF at 100kHz 1 V RMS up to 10nF at 1MHz

Above: (linearly decreasing with the impedance)
Programmable in 0.1V steps (maximum 1,5V RMS)

Measuring Speed:

	1kHz	10kHz	100kHz	1MHz					
From trig to end of measurement: *	20ms	20ms	6ms	6ms					
From trig to data ready: *	28ms	28ms	14ms	14ms					
Additional time per meas. by average	16ms	16ms	2ms	2ms					
*) allowing 3ms contact bouncing or 1 range change									

Multiple measurements (average):

The sum of each measurement (from trig to end of measurement) + 8ms for

calculation time

Measuring Cables: 1m (39,3 inch) from bridge module to fixture (Cables supplied by Danbridge)

Input Protection: 2 Joule up to 1kV or 4μF charged 1000V

Bias Voltage internal: Up to ±3,0VDC on generator terminal, set in 0,1V steps (internally generated)

	Frequency	1kHz		10kHz			Accuracy ±1 digit		
								Capacitance	Tan δ
Accuracy:		1pF	-	39pF	0,1pF	-	3,9pF	0,5%	± ,0010
		40pF	-	3,9μF	4pF	-	3,9µF	0,05%	± ,0002
		4μF	-	399μF	4μF	-	39μF	0,1%	± ,0007
		400μF	-	1mF	40μF	-	400μF	1%	± ,0020
		100kHz			1MHz				
		,03pF	-	,9pF	,01pF	-	3,9pF	0,5%*	± ,0010
		1pF	-	,9μF	4pF	-	0,9nF	,	± ,0002
					1nF	-	9,9nF	*	± ,0007
		1μF	-	9μF	10nF	-		0,2%	± ,0010
		10μF	-	40μF	30nF		99nF	1%	± ,0020

*Accuracy ± 0,2pF *Accuracy ± 2pF *Accuracy ± 0,2pF

Bin Sorting: Up to 12 limits for 1st parameter and 4 limits for 2nd parameter by opto-couplers

Interfaces: Rear panel: IEEE 488 (GPIB) and RS232C

Control: Measure end, data ready, trig ready, fault and status

Trig input: DC, AC and contact closure

Front panel: PC card for set-ups, save and loading

Environment:Ambient temperature
Warm-up time:
10-30 degrees Celsius
Minimum 30 minutes

Power: 90-130 and 200-260 V AC, 50-60 Hz,

Calibration interval: Minimum: Every 12 months

Dimensions: Mainframe:

Europe Overseas 140mm or 5,5 inch 30cm 32cm Height: Width: 438mm or 17,2 inch 51cm 52cm Depth: 360mm or 14,2 inch 56cm 55cm Weight: Total 16kg or 36 lb. 20kg 22kg

Export Packing

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